

SERESSA International School 12-16 Nov. 2018

Monday 12 November 2018

Radiation effects (SEE, TID, TNID) - Newton 1-2 (11:00 - 17:00)

time	[id] title	presenter
11:00	[7] TID and TNID	Mr POIVEY, Christian
12:15	[36] Single Event Effects (SEE): Mechanisms and Classifications	Dr BUCHNER, Stephen
14:30	[8] Single Event Effects Test Methods	Dr TAPERO, Konstantin
16:00	[9] SEE effects on VLSI devices (ASIC and FPGA)	Prof. STERPONE, Luca